

**Search Notes****Application/Control No.**

09/845,083

**Examiner**

David Lazaro

**Applicant(s)/Patent under Reexamination**

MANTEGNA ET AL.

**Art Unit**

2155

**SEARCHED**

Class	Subclass	Date	Examiner
709	231, 246	10/3/2005	DRL
713	401, 503	10/3/2005	DRL
375	356, 371	10/3/2005	DRL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST: USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB see history	10/11/2005	DRL
NPL: ACM, Citeseer, Google, IEEE, INSPEC, IP.com Focus: skew, latency, delay, heuristic, temporal redundancy, resampling	10/3/2005	DRL
PALM Inventor search	10/11/2005	DRL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner